# International Rectifier

# IRF1310NPbF

HEXFET® Power MOSFET

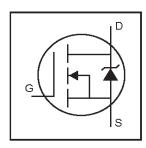
#### Advanced Process Technology

- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

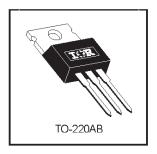
#### Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



$$V_{DSS} = 100V$$
 $R_{DS(on)} = 0.036\Omega$ 
 $I_D = 42A$ 



#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	42	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	30	Α
I <sub>DM</sub>	Pulsed Drain Current ①	140	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	160	W
	Linear Derating Factor	1.1	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy®	420	mJ
I <sub>AR</sub>	Avalanche Current①	22	A
E <sub>AR</sub>	Repetitive Avalanche Energy①	16	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting torque, 6-32 or M3 srew	10 lbf•in (1.1N•m)	

#### Thermal Resistance

	Parameter	Тур.	Max.	Units
R <sub>0</sub> JC	Junction-to-Case		0.95	
R <sub>ecs</sub>	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
Reja	Junction-to-Ambient		62	

# IRF1310NPbF

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_{D} = 250 \mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.11		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.036	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 22A ⊕
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
<b>g</b> fs	Forward Transconductance	14			S	$V_{DS} = 25V, I_{D} = 22A$
1	Drain to Source Looke as Current			25	μΑ	V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V
DSS	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
ı	Gate-to-Source Forward Leakage			100	- A	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V
Qg	Total Gate Charge			110		I <sub>D</sub> = 22A
Qgs	Gate-to-Source Charge			15	nC	V <sub>DS</sub> = 80V
$Q_{gd}$	Gate-to-Drain ("Miller") Charge			58		V <sub>GS</sub> = 10V, See Fig. 6 and 13 ⊕
t <sub>d(on)</sub>	Turn-On Delay Time		11			V <sub>DD</sub> = 50V
t <sub>r</sub>	Rise Time		56			I <sub>D</sub> = 22A
t <sub>d(off)</sub>	Turn-Off Delay Time		45		ns	$R_G = 3.6\Omega$
tf	Fall Time		40			$R_{\text{D}}$ = 2.9 $\Omega$ , See Fig. 10 $\oplus$
	Internal Drain Inductance		4.5		nH	Between lead,
L <sub>D</sub>	Internal Drain Inductance		4.5			6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5			from package
						and center of die contact
Ciss	Input Capacitance		1900			V <sub>GS</sub> = 0V
Coss	Output Capacitance		450		pF	V <sub>DS</sub> = 25V
Crss	Reverse Transfer Capacitance		230			f = 1.0MHz, See Fig. 5

#### **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Мах.	Units	Conditions
Is	Continuous Source Current			42		MOSFET symbol
	(Body Diode)	4.	42	A	showing the	
I <sub>SM</sub>	Pulsed Source Current			4.40		integral reverse
	(Body Diode) ①⑥		140	140	p-n junction diode.	
V <sub>SD</sub>	Diode Forward Voltage			1.3	٧	T <sub>J</sub> = 25°C, I <sub>S</sub> = 22A, V <sub>GS</sub> = 0V ⊕
t <sub>rr</sub>	Reverse Recovery Time		180	270	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 22A
Q <sub>rr</sub>	Reverse RecoveryCharge		1.2	1.8	μC	di/dt = 100A/µs ⊕
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- $\begin{tabular}{l} @ Starting $T_J=25^\circ$C, $L=1.7mH$ \\ $R_G=25\Omega$, $I_{AS}=22A$. (See Figure 12) \\ \end{tabular}$
- $\label{eq:loss_def} \begin{tabular}{ll} \begin{tabular}{ll} $I_{SD} \leq 22A, \; di/dt \leq 180A/\mu s, \; V_{DD} \leq V_{(BR)DSS}, \\ $T_{J} \leq 175^{\circ}C$ \end{tabular}$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .

## IRF1310NPbF

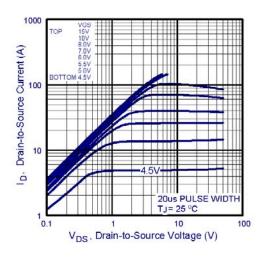


Fig 1. Typical Output Characteristics

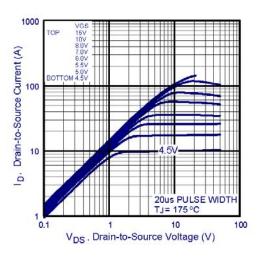


Fig 2. Typical Output Characteristics

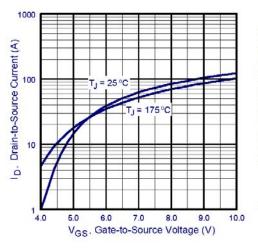


Fig 3. Typical Transfer Characteristics

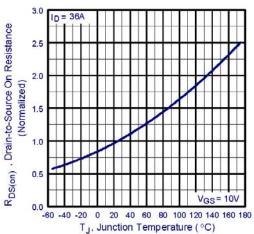


Fig 4. Normalized On-Resistance Vs. Temperature

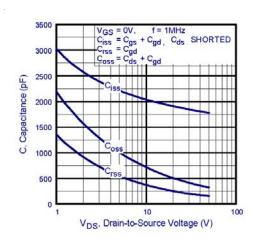


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

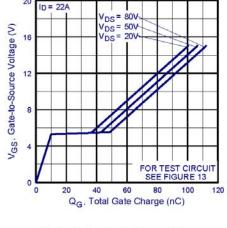


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

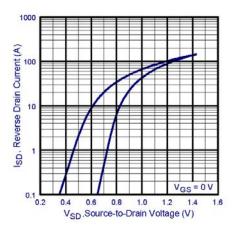


Fig 7. Typical Source-Drain Diode Forward Voltage

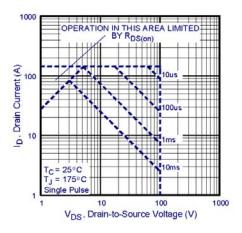


Fig 8. Maximum Safe Operating Area

# IRF1310NPbF

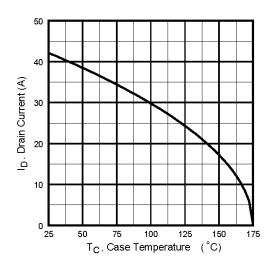


Fig 9. Maximum Drain Current Vs. Case Temperature

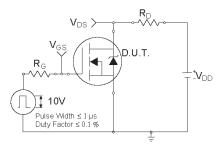


Fig 10a. Switching Time Test Circuit

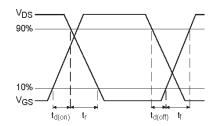


Fig 10b. Switching Time Waveforms

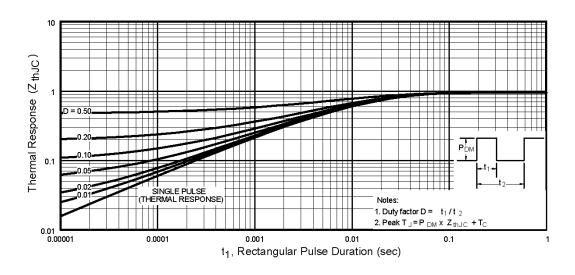


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

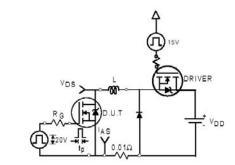


Fig 12a. Unclamped Inductive Test Circuit

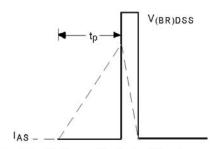


Fig 12b. Unclamped Inductive Waveforms

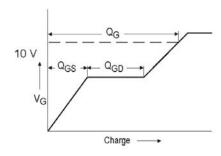


Fig 13a. Basic Gate Charge Waveform

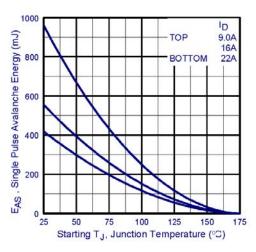


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

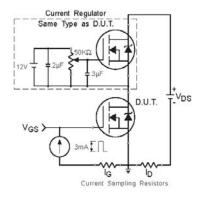
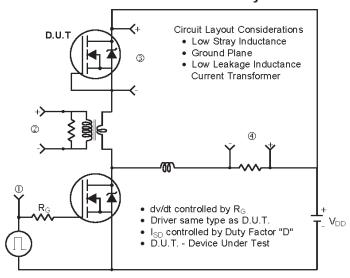
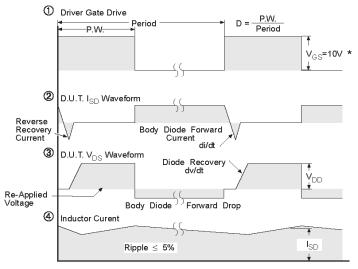


Fig 13b. Gate Charge Test Circuit

#### Peak Diode Recovery dv/dt Test Circuit



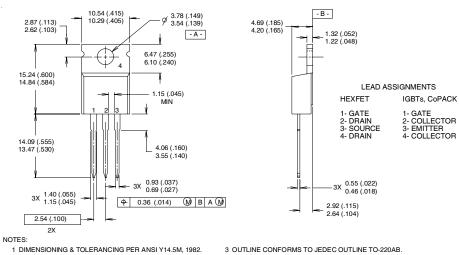


\*  $V_{GS}$  = 5V for Logic Level Devices

Fig 14. For N-Channel HEXFETS

## TO-220AB Package Outline

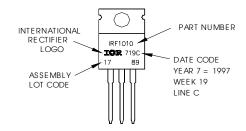
Dimensions are shown in millimeters (inches)



- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010 LOT CODE 1789 ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C" Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.8/04

Note: For the most current drawings please refer to the IR website at: <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>

#### IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

#### WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.